TOSHIBA Field Effect Transistor Silicon N-Channel MOS Type (U-MOS V-H)

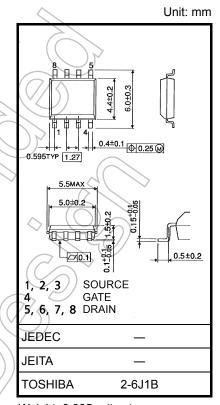
TPC8038-H

High-Efficiency DC-DC Converter Applications Notebook PC Applications Portable Equipment Applications

- Small footprint due to a small and thin package
- High-speed switching
- Small gate charge: QSW = 5.0 nC (typ.)
- Low drain-source ON-resistance: RDS (ON) = 7.6 m Ω (typ.)
- High forward transfer admittance: $|Y_{fs}| = 36 \text{ S (typ.)}$
- Low leakage current: $I_{DSS} = 10 \mu A (max) (V_{DS} = 30 V)$
- Enhancement mode: $V_{th} = 1.5$ to 2.5 V ($V_{DS} = 10$ V, $I_{D} = 1$ mA)

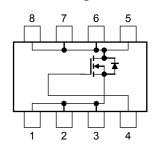
Absolute Maximum Ratings (Ta = 25°C)

			4		
Characteristic		Symbol	Rating	Unit	
Drain-source voltage		V_{DSS}	30	V	
Drain-gate voltage ($R_{GS} = 20 \text{ k}\Omega$)		V _{DGR}	30	y	
Gate-source voltage		V _{GSS}	±20	/ v	
Drain current	DC (Note 1)	I _D ((12	A	
Diain current	Pulsed (Note 1)	DP.	48	^	
Drain power dissipation (t = 10 s)		(PD)	1.9	W	
(Note 2a)			1.5		
Drain power dissipation (t = 10 s)		PD	1.0	w	
(Note 2b)			(070	7	
Single-pulse avalanche energy		EAS	94	mJ	
	(Note 3)	-A3		1110	
Avalanche current		I _{AR}	12	Α	
Repetitive avalanche energy		E _{AR}	0.18	mJ	
(Note 2a) (Note 4)		⊢AR	0.10	1110	
Channel temperature		Tch	150	°C	
Storage temperature range		T _{stg}	–55 to 150	°C	



Weight: 0.085 g (typ.)

Circuit Configuration



Note: For Notes 1 to 4, refer to the next page.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings.

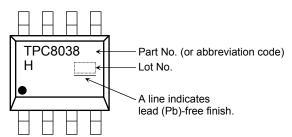
Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

This transistor is an electrostatic-sensitive device. Handle with care.

Thermal Characteristics

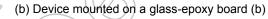
Characteristic	Symbol	Max	Unit	
Thermal resistance, channel to ambient $(t=10 \; s) \eqno(Note \; 2a)$	R _{th (ch-a)}	65.8	°C/W	
Thermal resistance, channel to ambient $(t=10 \; s) \eqno(Note \; 2b)$	R _{th (ch-a)}	125	°C/W	

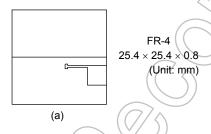
Marking (Note 5)

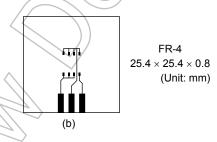


Note 1: Ensure that the channel temperature does not exceed 150°C.

Note 2: (a) Device mounted on a glass-epoxy board (a)







Note 3: $V_{DD} = 24 \text{ V}$, $T_{Ch} = 25^{\circ}\text{C}$ (initial), $L = 500 \mu\text{H}$, $R_G \neq 25 \Omega$, $I_{AR} = 12 \text{ A}$

Note 4: Repetitive rating: pulse width limited by max channel temperature

Note 5: • on lower left of the marking indicates Pin 1.

* Weekly code: (Three digits)

Week of manufacture

(01 for the first week of year, continuing up to 52 or 53)

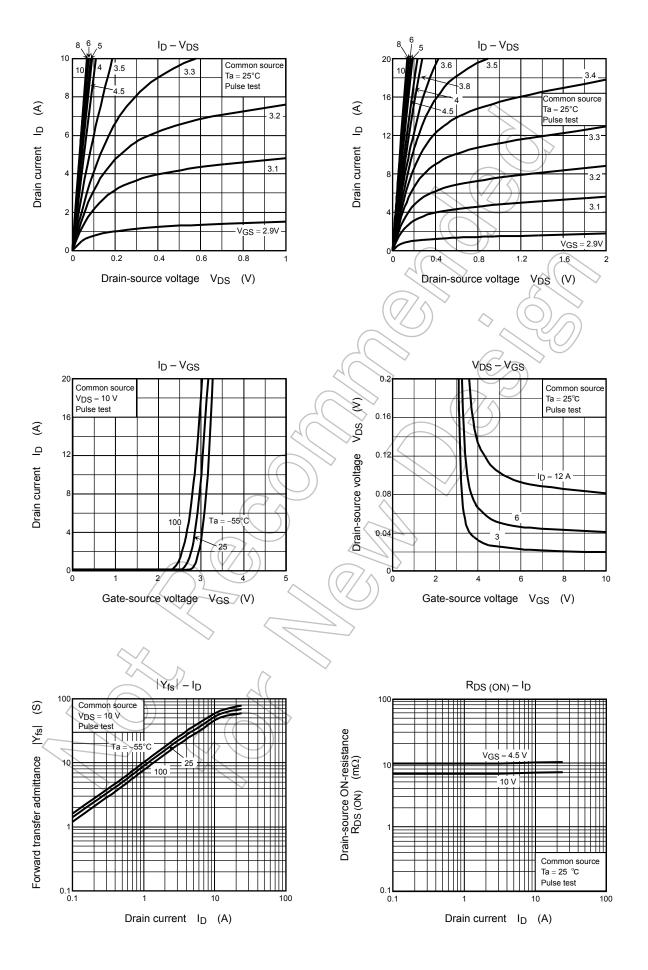
Year of manufacture (The last digit of the year)

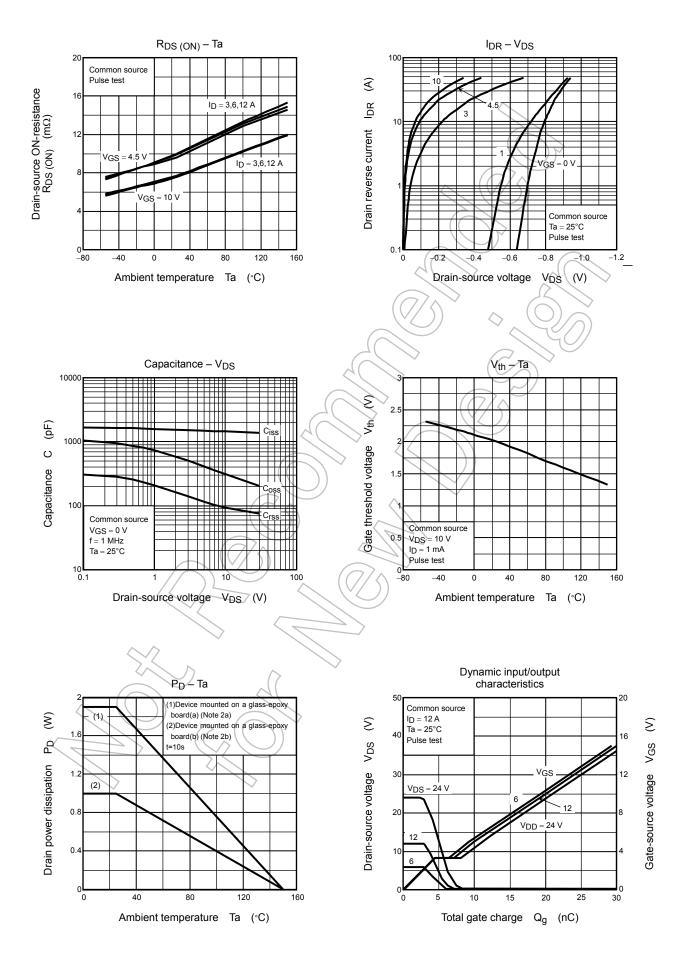
Electrical Characteristics (Ta = 25°C)

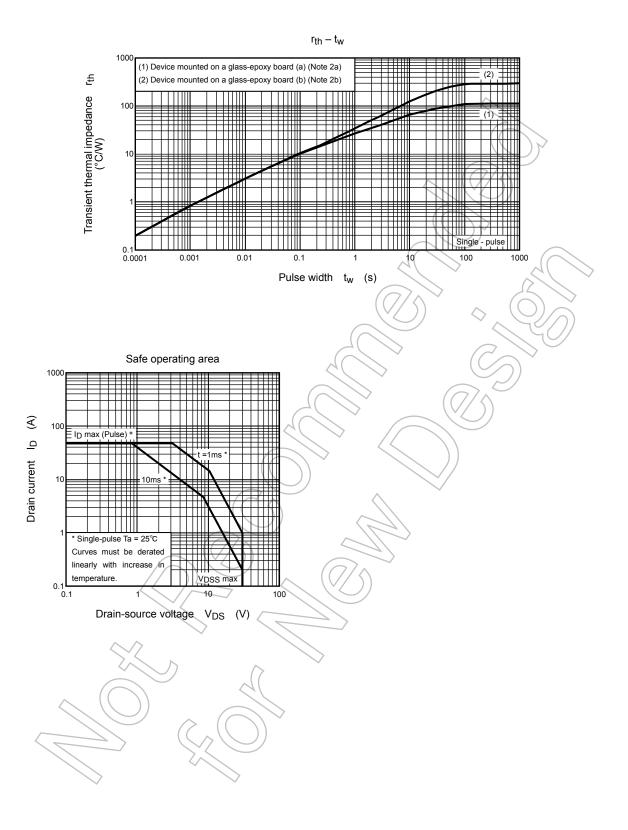
Cha	aracteristic	Symbol	Test Condition	Min	Тур.	Max	Unit	
Gate leakage curi	rent	I _{GSS}	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±100	nA	
Drain cutoff curre	nt	I _{DSS}	V _{DS} = 30 V, V _{GS} = 0 V	_	_	10	μА	
Drain-source breakdown voltage		V (BR) DSS	$I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$	30	_	_	V	
		V (BR) DSX	$I_D = 10 \text{ mA}, V_{GS} = -20 \text{ V}$	15		_		
Gate threshold vo	oltage	V_{th}	$V_{DS} = 10 \text{ V}, I_D = 1 \text{ mA}$	1.5) >_	2.5	>	
Drain-source ON-resistance		D	$V_{GS} = 4.5 \text{ V}, I_D = 6 \text{ A}$) / />	9.9	13.9	- mΩ	
		R _{DS} (ON)	V _{GS} = 10 V, I _D = 6 A	3	7.6	11.4		
Forward transfer	admittance	Y _{fs}	V _{DS} = 10 V, I _D = 6 A	18	36		S	
Input capacitance		C _{iss}	V _{DS} = 10 V, V _{GS} = 0 V, f = 1 MHz	_	1433	2150	pF	
Reverse transfer capacitance		C _{rss}		_	83	125		
Output capacitance		Coss		_ /	303	\rightarrow		
Gate resistance		Rg	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 5 \text{ MHz}$		3.4	> 5.1	Ω	
Switching time	Rise time	t _r	V _{GS} 10 V I _D = 6 A V _{OUT}		3,5) —		
	Turn-on time	t _{on}			10.5		ns	
	Fall time	t _f	4.7.7.2 W W.7.7.2 W W.7.2 W W.7.		11.0	l	- lis	
	Turn-off time	t _{off}	V _{DD} ≈ 15 V Duty ≤ 1%, t _w = 10 μs		35			
Total gate charge (gate-source plus gate-drain)		Qg	$V_{DD} \approx 24 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 12 \text{ A}$		21			
			$V_{DD} \approx 24 \text{ V}, V_{GS} = 5 \text{ V}, I_D = 12 \text{ A}$		11			
Gate-source charge 1		Q _{gs1}		_	4.4	_	nC	
Gate-drain ("Miller") charge		Q_{gd}	$V_{DD} \approx 24 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 12 \text{ A}$	_	3.7	_		
Gate switch charge		Q _{SW}		_	5.0	_		

Source-Drain Ratings and Characteristics (Ta = 25°C)

Characteristic	Symbol	Test Condition	Min	Тур.	Max	Unit
Drain reverse current Pulse (Note 1)	I _{DRP}	> -	_	_	48	Α
Forward voltage (diode)	/V _{DSF}	I _{DR} = 12 A, V _{GS} = 0 V	_	_	-1.2	V









• The information contained herein is subject to change without notice.

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